

Notice of References Cited	Application/Control No. 10/792,231		Applicant(s)/Patent Under Reexamination LIN, YU-KAI	
	Examiner Biju Chandran		Art Unit 2835	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0020152 A1	01-2003	Inoue et al.	257/684
*	B	US-2003/0068487 A1	04-2003	Nguyen et al.	428/323
*	C	US-5,971,566	10-1999	Tani et al.	362/294
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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